

High speed IGBT in Trench and Fieldstop technology

Features:

TRENCHSTOP[™] 1200V technology offering

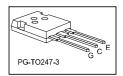
- very low V_{CEsat}
- low EMI
- maximum junction temperature 175°C
- qualified according to JEDEC for target applications
- Pb-free lead plating; RoHS compliant
- complete product spectrum and PSpice Models:

http://www.infineon.com/igbt/

Applications:

- uninterruptible power supplies
- welding converters
- · converters with high switching frequency





Туре	V CE	<i>l</i> c	$V_{CEsat}, T_{vj}=25^{\circ}C$	T vjmax	Marking	Package
IGW40N120H3	1200V	40A	2.05V	175°C	G40H1203	PG-TO247-3

Maximum ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current, limited by T_{vjmax} $T_{C} = 25^{\circ}C$ $T_{C} = 100^{\circ}C$	k	80.0 40.0	A
Pulsed collector current, t_{p} limited by T_{vjmax}	/ Cpuls	160.0	A
Turn off safe operating area $V_{CE} \le 1200V$, $T_{vj} \le 175^{\circ}C$	-	160.0	A
Gate-emitter voltage	V _{GE}	±20	V
Short circuit withstand time $V_{GE} = 15.0V$, $V_{CC} \le 600V$, $T_{vj} \le 175^{\circ}C$ Allowed number of short circuits < 1000 Time between short circuits: $\ge 1.0s$	<i>t</i> sc	10	μs
Power dissipation $T_{\rm C}$ = 25°C Power dissipation $T_{\rm C}$ = 100°C	Ptot	483.0 220.0	W
Operating junction temperature	T _{vj}	-40+175	°C
Storage temperature	T _{stg}	-55+150	°C
Soldering temperature, wavesoldering 1.6 mm (0.063 in.) from case for 10s		260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm



Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit	
Characteristic	·				
IGBT thermal resistance, junction - case	R _{th(j-c)}		0.31	K/W	
Thermal resistance junction - ambient	<i>R</i> th(j-a)		40	K/W	

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Demonster	Cumb al		Value			11
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Static Characteristic						
Collector-emitter breakdown voltage	V(BR)CES	V _{GE} = 0V, <i>I</i> _C = 0.50mA	1200	-	-	V
Collector-emitter saturation voltage	V∕CEsat	$V_{GE} = 15.0V, k = 40.0A$ $T_{vj} = 25^{\circ}C$ $T_{vj} = 125^{\circ}C$ $T_{vj} = 175^{\circ}C$	- - -	2.05 2.50 2.70	2.40 - -	v
Gate-emitter threshold voltage	V∕GE(th)	<i>I</i> _C = 1.00mA, <i>V</i> _{CE} = <i>V</i> _{GE}	5.0	5.8	6.5	V
Zero gate voltage collector current	<i>I</i> ces	V _{CE} = 1200V, V _{GE} = 0V <i>T</i> _{vj} = 25°C <i>T</i> _{vj} = 175°C	-	-	250.0 2500.0	μA
Gate-emitter leakage current	<i>I</i> GES	V _{CE} = 0V, V _{GE} = 20V	-	-	600	nA
Transconductance	g fs	<i>V</i> _{CE} = 20V, <i>I</i> _C = 15.0A	-	20.0	-	S

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Devenueder	Symbol		Value			Unit
Parameter	Symbol	Conditions	min.	typ.	max.	
Dynamic Characteristic						
Input capacitance	\mathcal{C}_{ies}		-	2330	-	pF
Output capacitance	Coes	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz	-	150	-	
Reverse transfer capacitance	Cres		-	130	-	
Gate charge	Q _G	V _{CC} = 960V, <i>I</i> _C = 40.0A, V _{GE} = 15V	-	185.0	-	nC
Internal emitter inductance measured 5mm (0.197 in.) from case	LΕ		-	13.0	-	nH
Short circuit collector current Max. 1000 short circuits Time between short circuits: ≥ 1.0s	Ic(sc)	<i>V</i> _{GE} = 15.0V, <i>V</i> _{CC} ≤ 600V, <i>T</i> _{vj} ≤ 175°C, <i>t</i> _{SC} ≤ 10μs	-	139	-	A



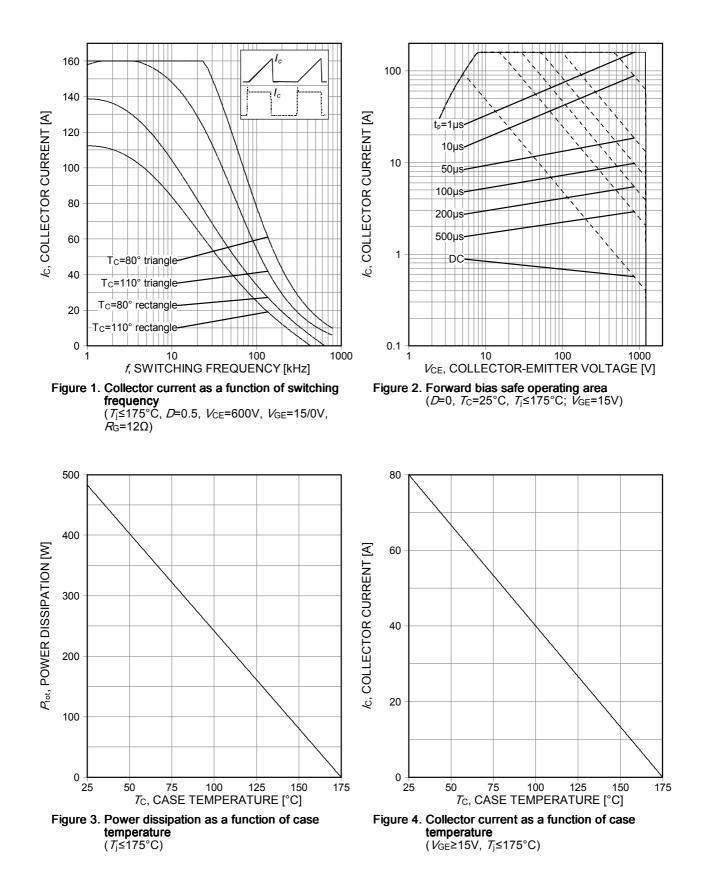
Switching Characteristic, Inductive Load, at $T_{vj} = 25^{\circ}C$

Parameter	0h.al	Conditions	Value			
	Symbol		min.	typ.	max.	Unit
IGBT Characteristic	·					•
Turn-on delay time	<i>t</i> d(on)	$T_{\rm vj} = 25^{\circ}{\rm C},$	-	30	-	ns
Rise time	t _r	$V_{CC} = 600V, I_C = 40.0A,$ $V_{GE} = 0.0/15.0V,$ $I_G = 12.0\Omega, L_{\sigma} = 70nH,$ $C_{\sigma} = 67pF$ L_{σ}, C_{σ} from Fig. E Energy losses include "tail" and diode (IKW40N120H3) reverse recovery.	-	57	-	ns
Turn-off delay time	<i>t</i> d(off)		-	290	-	ns
Fall time	<i>t</i> f		-	16	-	ns
Turn-on energy	Eon		-	3.20	-	mJ
Turn-off energy	E _{off}		-	1.20	-	mJ
Total switching energy	Ets		-	4.40	-	mJ

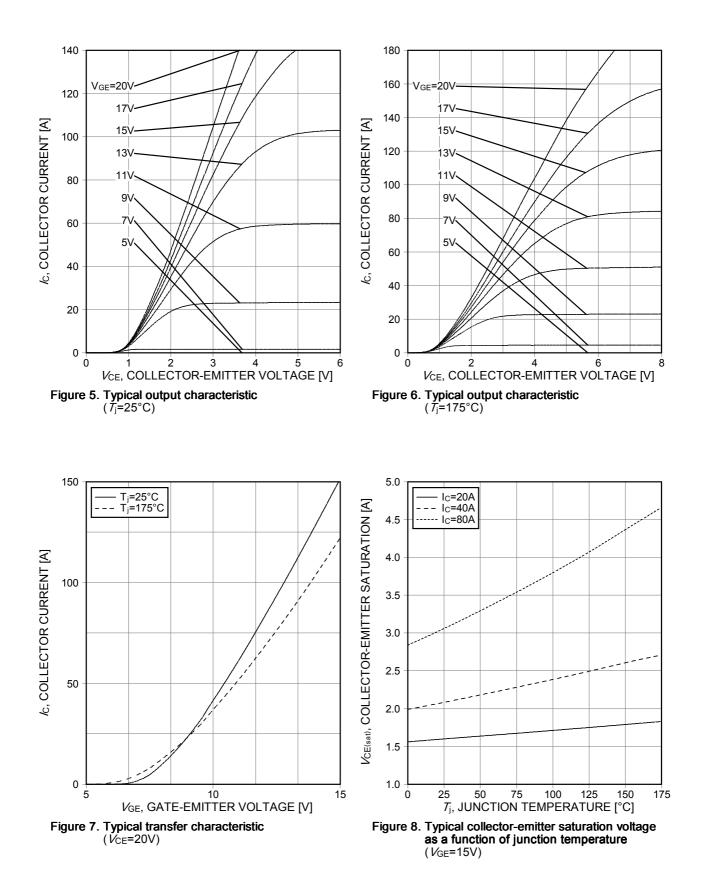
Switching Characteristic, Inductive Load, at T_{vj} = 175°C

Parameter	O. make at		Value			11
	Symbol	Conditions	min.	typ.	max.	Unit
IGBT Characteristic	·					-
Turn-on delay time	<i>t</i> d(on)	$T_{vj} = 175 ^{\circ}C,$ $V_{CC} = 600V, I_{C} = 40.0A,$ $V_{GE} = 0.0/15.0V,$ $T_{G} = 12.0\Omega, L_{\sigma} = 70$ nH, $C_{\sigma} = 67$ pF L_{σ}, C_{σ} from Fig. E Energy losses include "tail" and diode (IKW40N120H3) reverse recovery.	-	29	-	ns
Rise time	<i>t</i> r		-	49	-	ns
Turn-off delay time	<i>t</i> d(off)		-	366	-	ns
Fall time	<i>t</i> f		-	48	-	ns
Turn-on energy	Eon		-	4.40	-	mJ
Turn-off energy	Eoff		-	2.60	-	mJ
Total switching energy	Ets		-	7.00	-	mJ

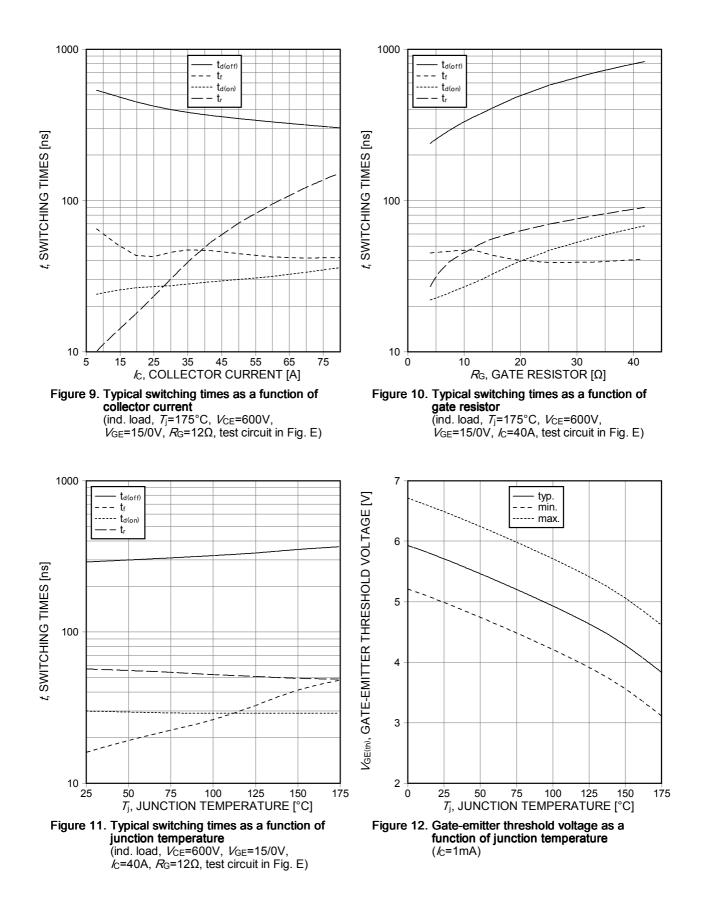




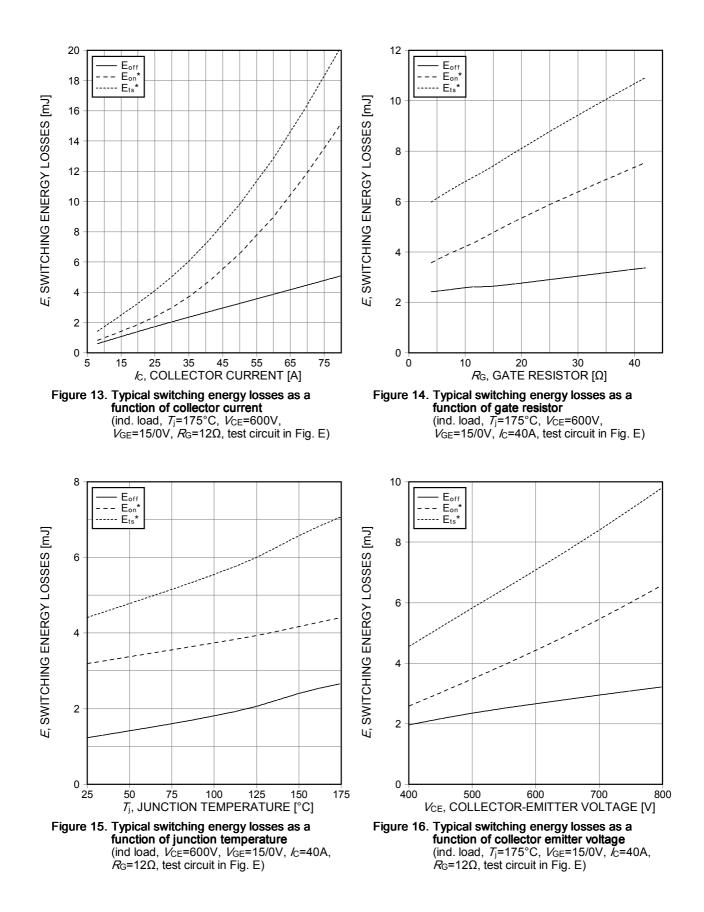






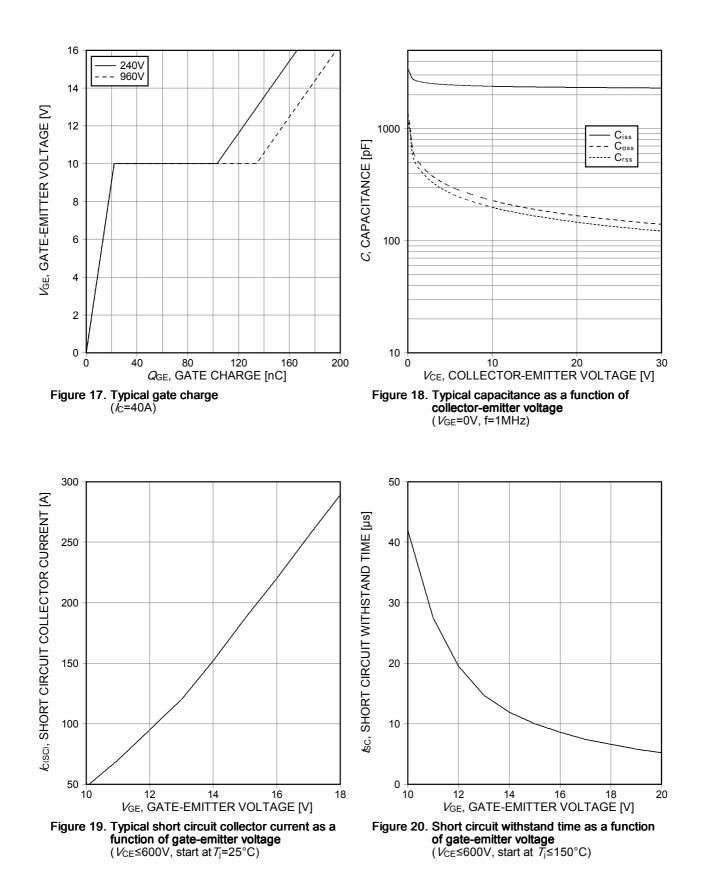






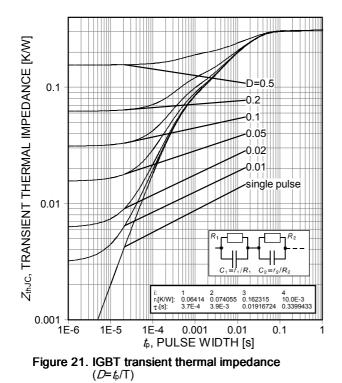


IGW40N120H3





IGW40N120H3





E1

E2

E3

e N

L

L1

øP

Q S 13.10

3.68

1.68

19.80

4.17

3.50

5.49

6.04

14.15

5.10

2.60

20.31

4.47

3.70

6.00

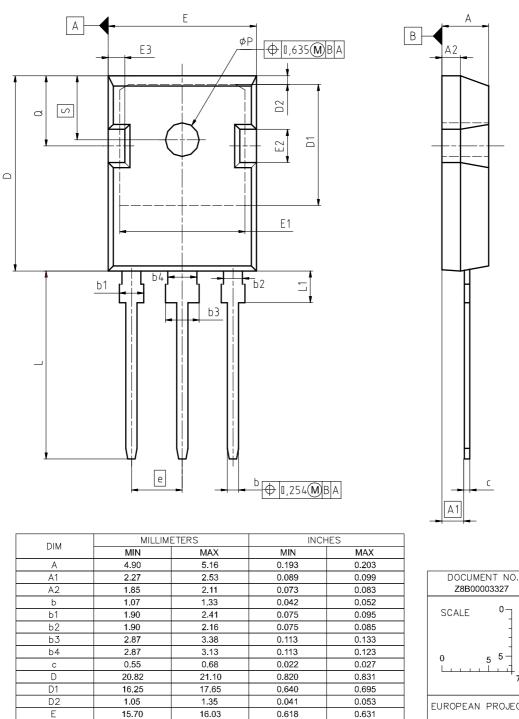
6.30

5.44

3

High speed switching series third generation

PG-TO247-3





7.5mm

0.516

0.145

0.066

0.780

0.164

0.138

0.216

0.238

0.557

0.201

0.102

0.799

0.176

0.146

0.236

0.248

0.214

3



IGW40N120H3

10% /_{rrm}

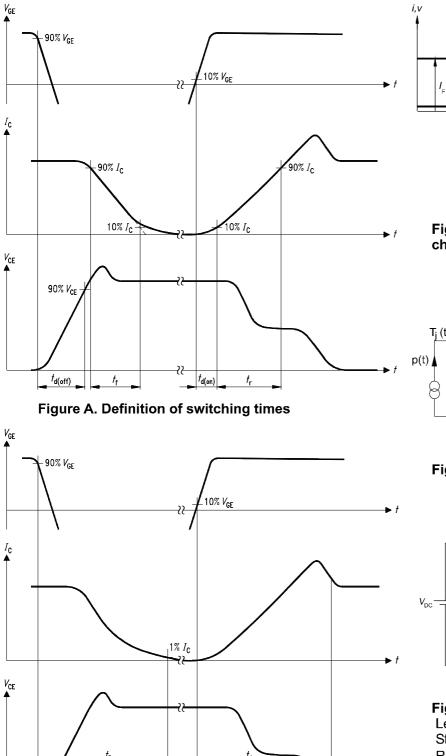
di /dt

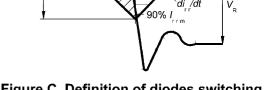
t

 $V_{_{\rm R}}$

High speed switching series third generation

di_/dt





 $t_r = t_s + t_F$ $Q_{\downarrow} = Q_{\downarrow} + Q_{\downarrow}$

Q

Figure C. Definition of diodes switching characteristics

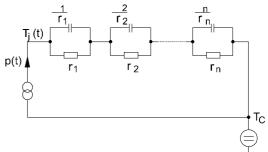


Figure D. Thermal equivalent circuit

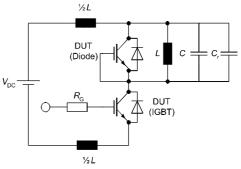


Figure E. Dynamic test circuit Leakage inductance L= 180nH, Stray capacitor $C_{\sigma} = 40 pF$, Relief capacitor C_r = 1nF (only for ZVT switching)

Figure B. Definition of switching losses

 t_2

t3

 $E_{\rm ON} = \int V_{\rm CE} \times I_{\rm C} \times {\rm d}t$

 $E_{\text{OFF}} = \int V_{\text{CE}} \times I_{\text{C}} \times dt$

*†*₁

3% V_{CE}

t,



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